## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/576,804	HWANG ET AL.
Examiner	Art Unit

1627

LAYLA SOROUSH

SEARCHED					
Class	Subclass	Date	Examiner		
424	401	8/13/2010	LS		
		1			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
525	94	8/13/2010	LS		
526	72	8/13/2010	LS		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
stic: composition claimed and odp	8/13/2010	LS		
inventors search edan and east	8/13/2010	LS		